

Test Report

No.: KA/2007/61077

Date: 2007/06/20

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RALEC ELECTRONIC CORPORATION NO. 1, CENTRAL 2ND STREET, NANTZE EXPORT PROCESSING ZONE, KAOHSIUNG, TAIWAN



The following sample(s) was/were submitted and identified by/on behalf of the client as:

Sample Description

: LEAD FREE CHIP RESISTOR PRODUCT

Style/Item No.

RTT03(0603T)RTT03J101

Sample Receiving Date

2007/06/11

Testing Period

: 2007/06/11 TO 2007/6/20

Test Requested

: In accordance with the RoHS Directive 2002/95/EC, and its

amendment directives.

Test Method

(1) With reference to US EPA Method 3050B for Lead Content. Analysis

was performed by ICP-AES.

Test Result(s)

Please refer to next page(s).

Katherine Ho / Supervisor Signed for and on behalf of SGS Taiwan Limited